


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574001	<b>Applicant(s)/Patent Under Reexamination</b>  KENMOKU ET AL.
	<b>Examiner</b>  SHANE FANG	<b>Art Unit</b>  4131

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
528	272	12/22/2008	sf

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
inventor searched, STIC searched	12/22/2008	sf

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

--	--